Form PTO-1449 (REV. 1/06)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 122005			APPLICATION NO. 10/517,423			
INFORMATION DISCLOSURE STATEMENT										
	(Use	e several sheets if necessary)		APPLICANT(S) Albert DURANTON et al.						
				FILING DATE March 10, 2005			GROUP 1611			
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	1		OTHER I	OCUME	NTS					
Examiner Initials	Cite No. Including name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published									
EXAMINER					I	DATE C	CONSIDERED			
Examiner:		citation considered, whether or not citation				ough cit	ation if not in	conformance		

Date: November 9, 2009

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(Use several sheets if necessary)					APPLICANT(S) Albert DURANTON et al.						
					DATE 10, 2005	GROUP 1611					
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